

Notice of References Cited	Application/Control No. 10/601,916	Applicant(s)/Patent Under Reexamination CHEN, SHIOW-HUI	
	Examiner Janet M. Wilkens	Art Unit 3637	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0016571	01-2005	Wu, Weidan	135/020.1
	B	US-2002/0121297	09-2002	Li et al.	135/20.1
	C	US-6,196,242	03-2001	Xu, Zhen Miao	135/20.1
	D	US-5,937,882	08-1999	Harbaugh, Kenneth A.	135/20.3
	E	US-6,014,980	01-2000	Glatz, Gustav Adolf	135/20.1
	F	US-6,401,739	06-2002	Bright et al.	135/98
	G	US-5,735,302	04-1998	Saliva, Fortunato	135/20.1
	H	US-5,785,069	07-1998	Glatz, Gustav Adolf	135/20.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	3307718	09-1984	Germany	Seidel	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Am. Vel 2/19/05